

**Search Notes**

Application/Control No.

10/525,766

Examiner

Linh T. Nguyen

Applicant(s)/Patent under  
Reexamination

HORIKAWA ET AL.

Art Unit

2627

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text searched on East and foreign application.	5/12/2006	LN